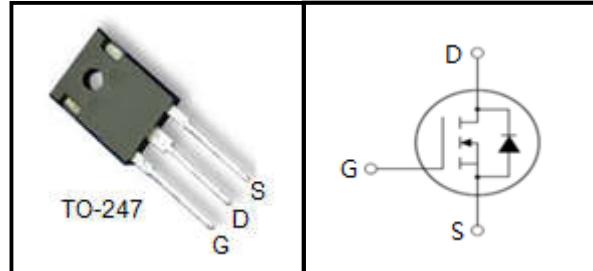


## 650V Super-Junction Power MOSFET

### FEATURES

- $BV_{DSS}=650\text{ V}$ ,  $I_D=62\text{ A}$
- $R_{DS(on)}:0.046\Omega$  (Max) @  $V_{GS}=10\text{ V}$
- Very low FOM  $R_{DS(on)} \times Q_g$
- 100% avalanche tested
- RoHS compliant
- Ultra-fast body diode
- Very high commutation ruggedness



### APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

### Device Marking and Package Information

Device	Package	Marking
MPSW65M046CFD	TO-247	MP65M046CFD

### Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ , unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-Source Voltage ( $V_{GS} = 0\text{ V}$ )	$V_{DSS}$	650	V
Continuous Drain Current	$I_D$	62	A
Pulsed Drain Current (note1)	$I_{DM}$	216	A
Gate-Source Voltage	$V_{GSS}$	$\pm 30$	V
Single Pulse Avalanche Energy (note2)	$E_{AS}$	2089	mJ
Avalanche Current (note1)	$I_{AR}$	15	A
Repetitive Avalanche Energy (note1)	$E_{AR}$	3	mJ
MOSFET dv/dt ruggedness, $V_{DS}=0\text{...}400\text{ V}$	dv/dt	50	V/ns
Reverse diode dv/dt, $V_{DS}=0\text{...}400\text{ V}$ , $I_{SD} \leq I_D$	dv/dt	50	V/ns
Power Dissipation ( $T_C = 25^\circ\text{C}$ )	$P_D$	481	W
Operating Junction and Storage Temperature Range	$T_J$ , $T_{stg}$	-55~+150	°C

### Thermal Resistance

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case, Max.	$R_{thJC}$	0.26	K/W
Thermal Resistance, Junction-to-Ambient, Max.	$R_{thJA}$	62	



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MPSW65M046CFD

**Specifications  $T_J = 25^\circ\text{C}$ , unless otherwise noted**

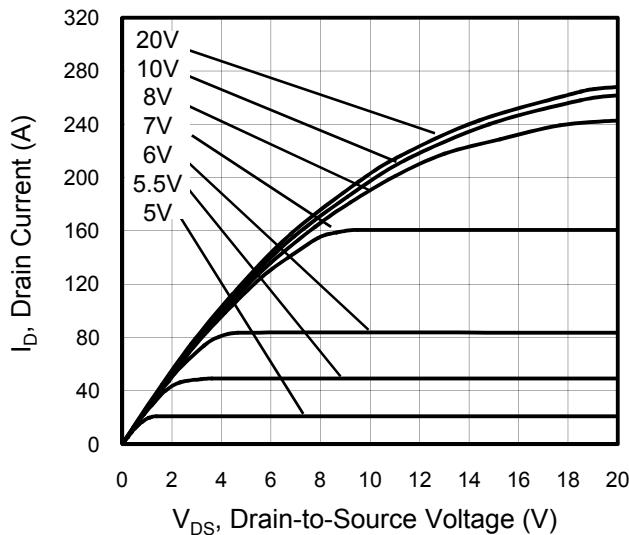
Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	650	--	--	V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}} = 650\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 25^\circ\text{C}$	--	--	5	$\mu\text{A}$
		$V_{\text{DS}} = 650\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 150^\circ\text{C}$	--	--	2000	
Gate-Source Leakage	$I_{\text{GSS}}$	$V_{\text{GS}} = \pm 30\text{V}$	--	--	$\pm 100$	nA
Gate-Source Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 0.25\text{mA}$	3.0	--	5.0	V
Drain-Source On-Resistance (Note3)	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 10\text{V}, I_D = 36\text{A}$	--	0.040	0.046	$\Omega$
Gate Resistance	$R_G$	$f = 1.0\text{MHz}$ , open drain	--	1.94	--	$\Omega$
<b>Dynamic</b>						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 50\text{V}, f = 1.0\text{MHz}$	--	7360	--	$\text{pF}$
Output Capacitance	$C_{\text{oss}}$		--	790	--	
Reverse Transfer Capacitance	$C_{\text{rss}}$		--	30	--	
Effective output capacitance, energy related	$C_{\text{o(er)}}$	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\ldots 400\text{V}$	--	250	--	
Effective output capacitance, time related	$C_{\text{o(tr)}}$	$I_D=\text{constant}, V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\ldots 400\text{V}$	--	1350	--	
Total Gate Charge	$Q_g$	$V_{\text{DD}} = 520\text{V}, I_D = 62\text{A}, V_{\text{GS}} = 10\text{V}$	--	143	--	$\text{nC}$
Gate-Source Charge	$Q_{\text{gs}}$		--	27	--	
Gate-Drain Charge	$Q_{\text{gd}}$		--	41	--	
Turn-on Delay Time	$t_{\text{d(on)}}$	$V_{\text{DD}} = 400\text{V}, I_D = 44.4\text{A}, V_{\text{GS}} = 13\text{V}, R_G = 1.9\Omega$	--	22	--	$\text{ns}$
Turn-on Rise Time	$t_r$		--	10	--	
Turn-off Delay Time	$t_{\text{d(off)}}$		--	120	--	
Turn-off Fall Time	$t_f$		--	8	--	
<b>Drain-Source Body Diode Characteristics</b>						
Continuous Body Diode Current	$I_s$	$T_C = 25^\circ\text{C}$	--	--	62	$\text{A}$
Pulsed Diode Forward Current	$I_{\text{SM}}$		--	--	216	
Body Diode Voltage	$V_{\text{SD}}$	$T_J = 25^\circ\text{C}, I_{\text{SD}} = 62\text{A}, V_{\text{GS}} = 0\text{V}$	--	0.9	1.2	V
Reverse Recovery Time	$t_{\text{rr}}$	$V_R = 400\text{V}, I_F = 62\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$	--	250	--	$\text{ns}$
Reverse Recovery Charge	$Q_{\text{rr}}$		--	1.8	--	$\mu\text{C}$
Peak Reverse Recovery Current	$I_{\text{rrm}}$		--	14	--	A

**Notes**

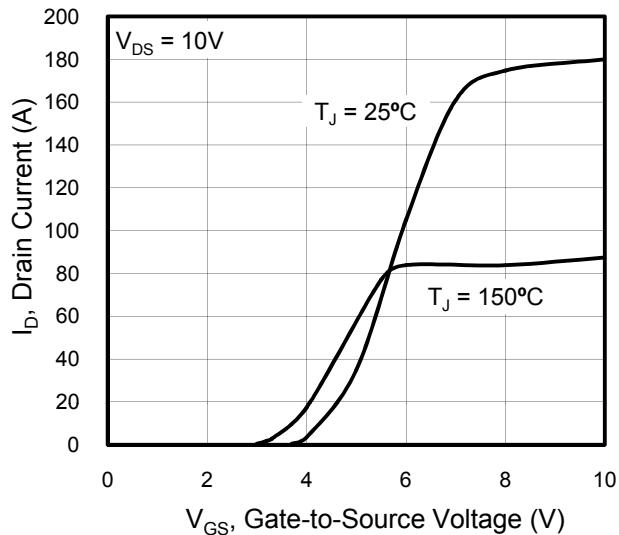
- Repetitive Rating: Pulse width limited by maximum junction temperature
- $I_{\text{AS}} = 15\text{A}, V_{\text{DD}} = 50\text{V}, R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$
- Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 1\%$

**Typical Characteristics**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

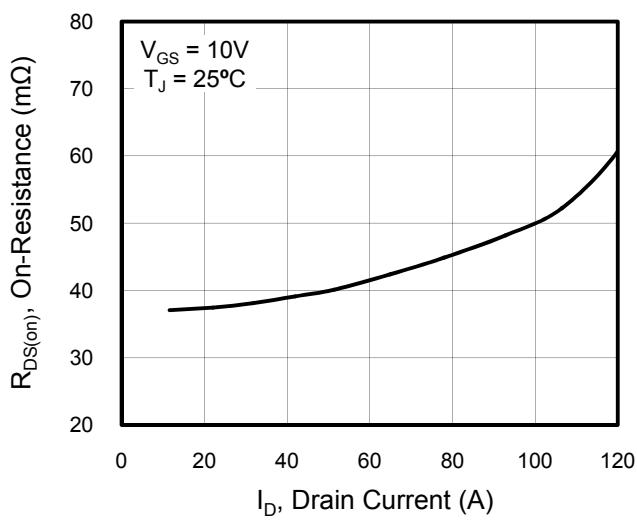
**Figure 1. Output Characteristics**



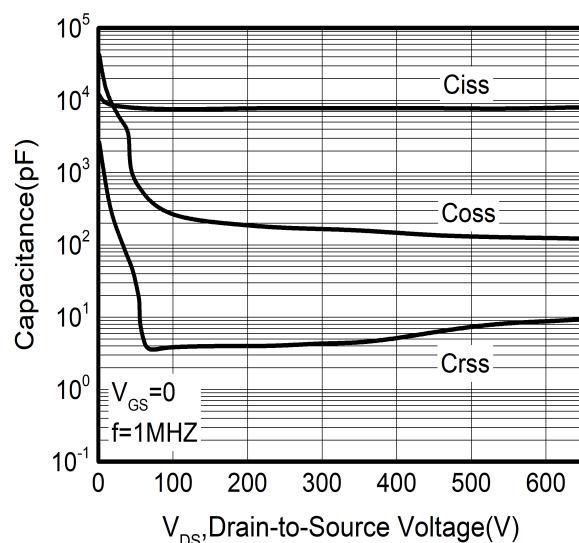
**Figure 2. Transfer Characteristics**



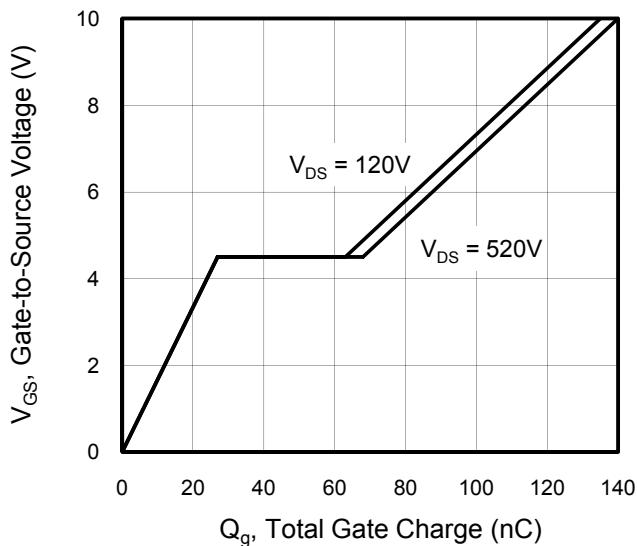
**Figure 3. On-Resistance vs. Drain Current**



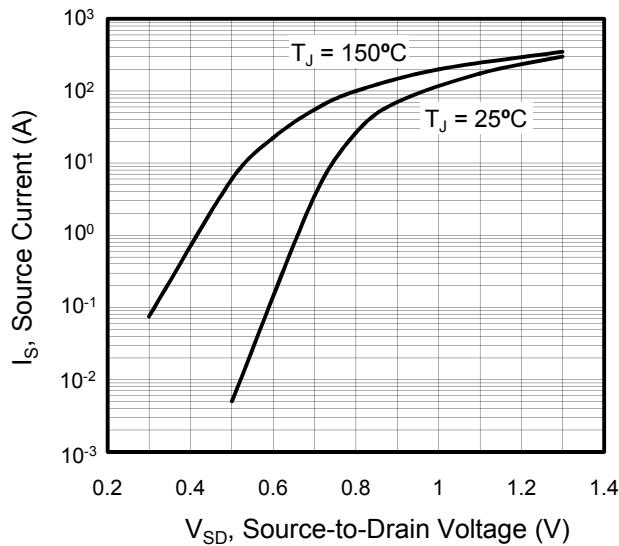
**Figure 4. Capacitance**



**Figure 5. Gate Charge**

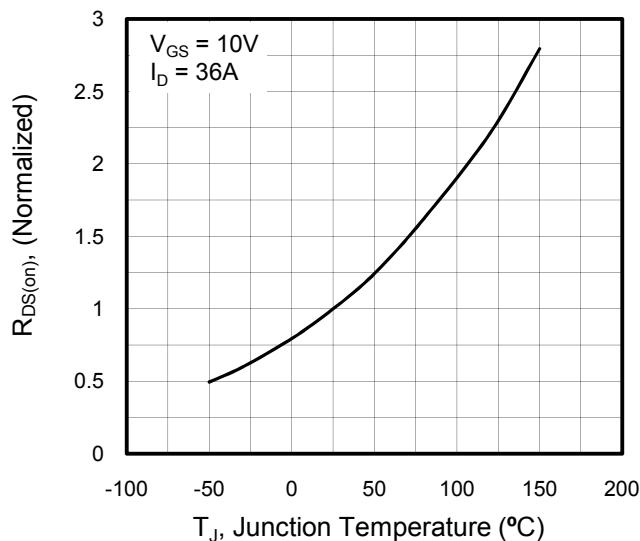


**Figure 6. Body Diode Forward Voltage**

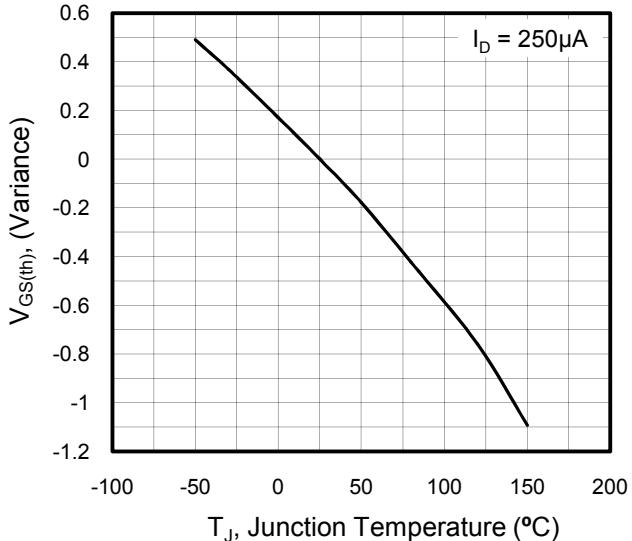


**Typical Characteristics**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

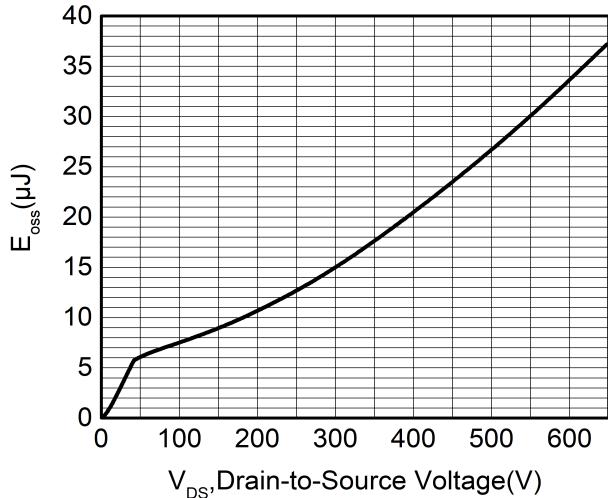
**Figure 7. On-Resistance vs. Temperature**



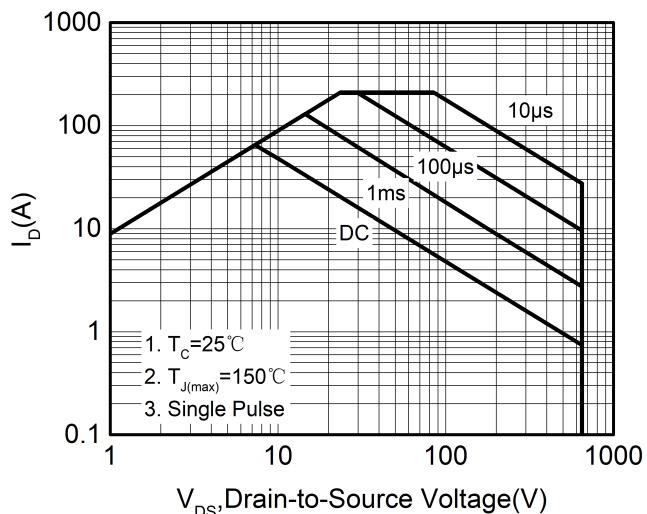
**Figure 8. Threshold Voltage vs. Temperature**



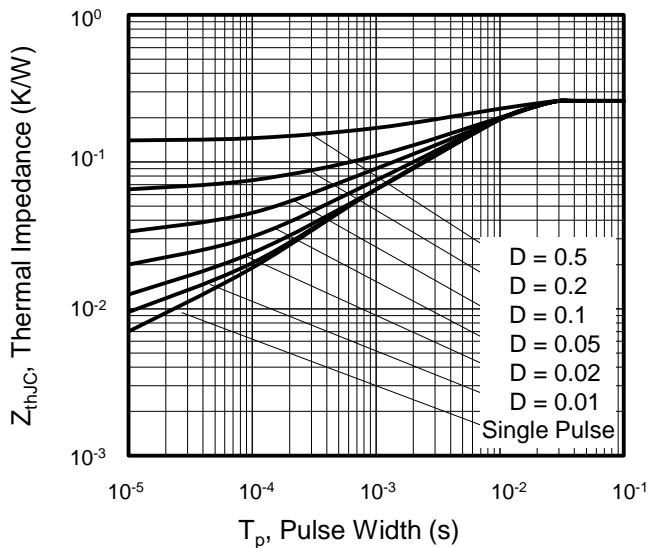
**Figure 9.  $C_{oss}$  stored energy**

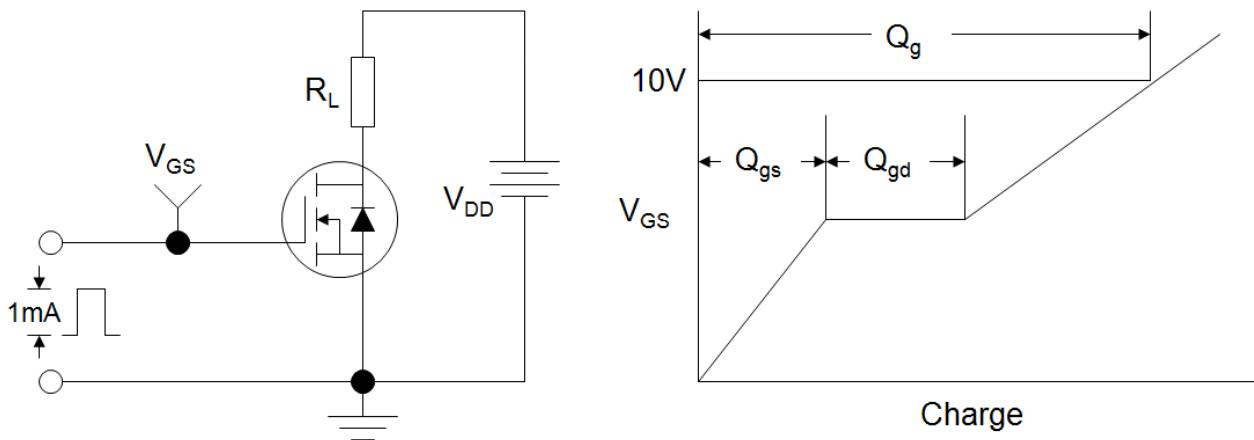
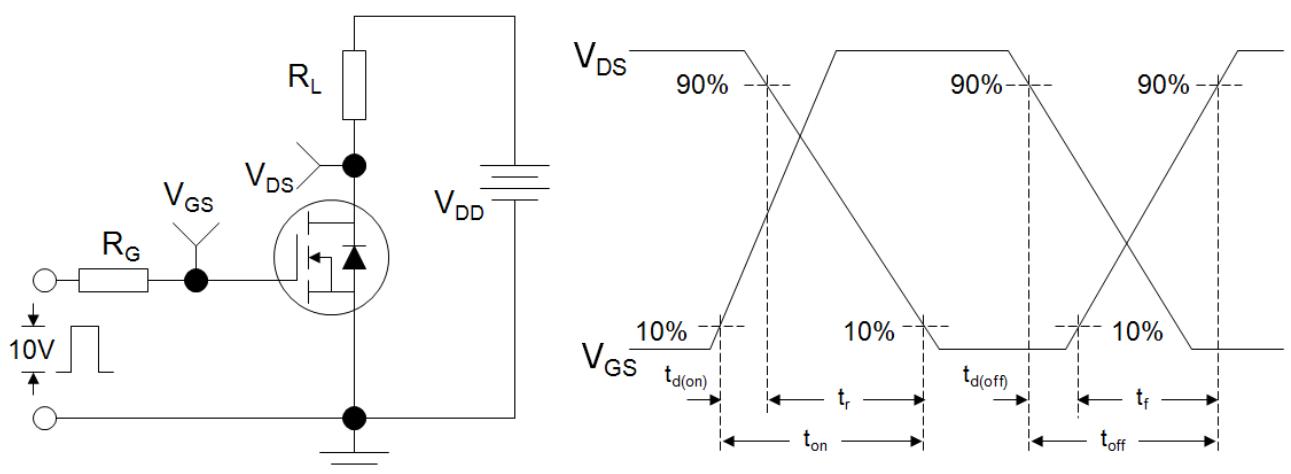
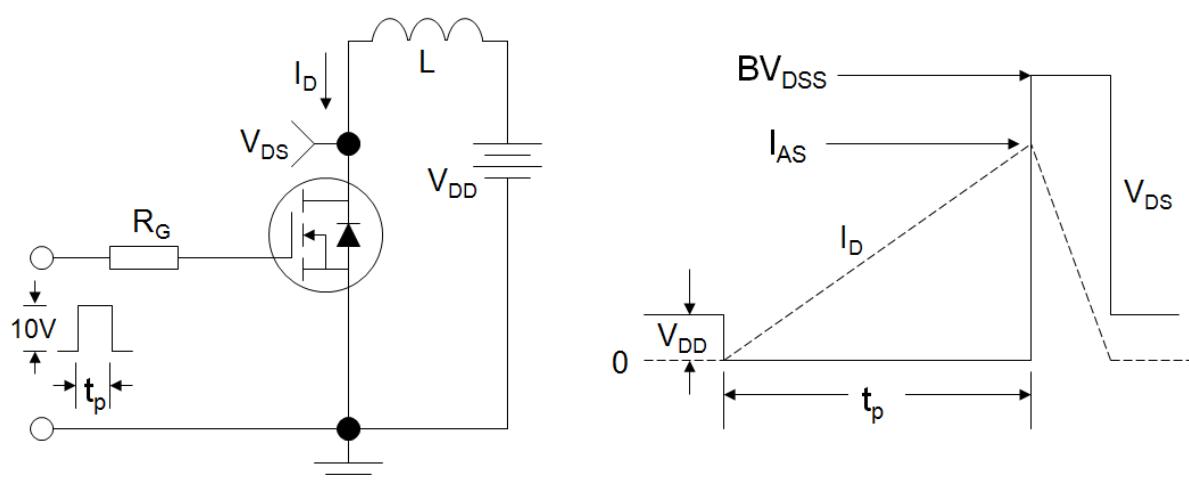


**Figure 10. Safe Operating Area**



**Figure 11. Transient Thermal Impedance**



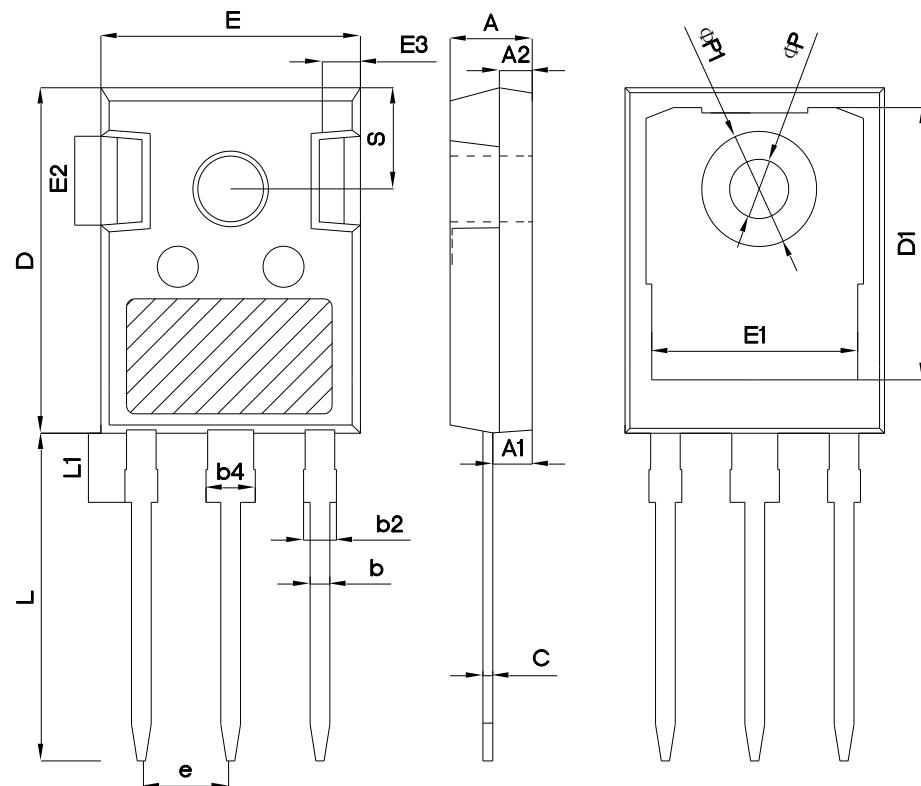
**Figure A: Gate Charge Test Circuit and Waveform**

**Figure B: Resistive Switching Test Circuit and Waveform**

**Figure C: Unclamped Inductive Switching Test Circuit and Waveform**




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**MPSW65M046CFD**

TO-247



SYMBOL	mm		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.21	2.41	2.59
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b2	1.91	2.01	2.21
b4	2.91	3.01	3.21
c	0.51	0.61	0.75
D	20.80	21.00	21.30
D1	16.25	16.55	16.85
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.80	5.00	5.20
E3	2.30	2.50	2.70
e	5.44BSC		
L	19.82	19.92	20.22
L1	-	-	4.30
ΦP	3.40	3.60	3.80
ΦP1	-	-	7.30
S	6.15BSC		



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MPSW65M046CFD

**Revision: 2021-10-18, Ver 1.2**

Revision	Date	Subjects (major changes since last revision)
1.1	2019-05-30	Initial version
1.2	2021-10-18	Parameters and fig